Notice of References Cited Application/Control No. 10/644,276 Examiner Djenane M. Bayard Applicant(s)/Patent Under Reexamination RAO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0014373	01-2003	Perge et al.	705/80
*	В	US-7,069,308	06-2006	Abrams, Jonathan H.	709/218
*	С	US-2003/0217106	11-2003	Adar et al.	709/206
*	D	US-2002/0194334	12-2002	Focant et al.	709/225
*	E	US-2002/0040310	04-2002	Lieben et al.	705/7
	F	US-			
	G	US-			
	н	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0				· · · · · · · · · · · · · · · · · · ·	
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*	T	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.